In all investigations concerning pressure influence on superconducmain attention is given to the change of the critical temperature $T_{\rm e}$ and $\tau_{\rm e}$ magnetic field $H_{\rm e}$ [3]. In [4] it was considered that $2\,\Delta/kT_{\rm e}$ does not characteristic.

One of the direct experimental methods for the study of the energy One of the direct experimental methods for the setuly of the energy experimental superconductors is the electron tunnelling technique. Possibilities of finest instrument allowed to find out a change of $2A/kT_{\rm e}$ with pressure at the setuly of the energy experimental superconductors.

This paper presents results on tunnelling investigations of the energy $g_{\rm sp}$ In and Tl under pressure.

2. Experimental Technique

2.1 Samples

As is known [7] the best gaps can be obtained on superconductor-harsuperconductor tunnel systems. This made superconducting diodes useful investigations under pressure. Of all systems investigated the best are particular to the best are par prepared on Al base, i.e. an Al-Al₂O₃ superconductor.

Al–I–In and Al–I–Tl samples were prepared by deposition in high (l \times 10 $^{\circ}$ T $^{\circ}$ vacuum on a cooled (up to 80 to 100 °K) glass slide 4×16 mm². There we vacuum on a cooled (up to so to 100 K) glass since 4×10 mm². There we three junctions on one slide, each $1_{\rm Al}\times0.5_{\rm In}$, $7_{\rm I}$ mm² (Fig. 1). To avoid eleffects films were deposited through stencils supported by an electromagnetic of the support of the suppor Junction quality in the sense of fitness for their use in pressure measurement much depended on condensation and oxidation conditions of the Al to-Aluminium was sprayed from a tungsten U-vaporizer. During deposition vacuum did not become worse due to preliminary long annealing (up to vacuum restoration) of the vaporizer and the hinge. Oxidation took place in the almost phere of dry air at a pressure of 0.2 Torr for 5 min. Sample preparation was controlled by film and junction resistance measurements both during deposit and subsequent heating up to room temperatures. Junctions with resistant 50 to 100 Ω were chosen. Al-I-Tl samples were covered with Si monoxide. about 1 µm thickness. In and Tl film thickness was determined by Linnick microinterferometer MII-4 and was equal to (1000 ± 100) A. For TI films

All films had resistivities of 4000 to 6400 Ω mm², and their initial critical temperature varied from 1.65 to 2 °K.

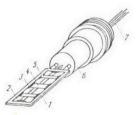


Fig. 1. Tunnel sample and obturator, 1 Sample holder made getinax, 2 indium contacts, 3 Affilm, 4 In and TI films, 5 cert glass, 6 obturator, 7 electrical wires

2.2 High pressure technique

thigh pressure bomb with kerosene-oil mixture [8] was used in all investi-. Pressure was created at room temperature and controlled by a hydraulic Alle manometer. Here an almost linear change of tunnel junction resistance $R(0) = 100 \Omega$, $dR/dp = 6 \Omega/katm$) was a reliable indication. Sensitiof junction resistance to pressures gave the possibility of rejecting samples re immersing into liquid helium. The final pressure in the bomb at low peratures was calculated from $T_{\rm c}$ changes of an In wire [9]:

$$T_{\rm c} = 4.36 \times 10^{-5} \; p \, + \, 5.2 \times 10^{-10} \; p^2$$
 .

dectrical conductors were introduced into the obturator, this allowed meaments to be carried out simultaneously, by means of a 4-probe system, the critical temperature of films, the In wire, and corresponding tunnel atacteristics.

2.3 Cryogenics and measuring apparatus

Low temperature measurements were carried out in a metal cryostat where * as possible to get temperatures from 4.2 to 1.15 °K. The bomb with samples

During the experiments the voltage-current characteristic was measured both onstant voltage and constant current conditions. Depending on the conand dI/dU or (dU/dI)-U at a modulation frequency of 383 Hz were plotted. Ill tunnel characteristics were recorded automatically on a X-Y coordinate 17.09-type register. Constant voltage at a sample was measured by a highmic potentiometer to within $\approx 1\,\mu\text{V}$ during recording.

3. Results and Discussion

Indium: After preparation Al-I-In samples were annealed for some days from temperature. The critical temperature of In films practically did not ter from T_c for massive pure indium. The halfwidth of the superconducting action did not exceed 0.01 °K for all pressures. Table 1 gives the change of ntical temperature for the film which is found to be

$$rac{{
m d}T_{
m c}}{{
m d}p} = \, - \, (3.65 \pm 0.15) imes 10^{-5} \, rac{{
m ^{\circ}K}}{{
m atm}} \, ,$$

Table 1 T_c and 2 Δ of indium under pressure

p katm)	$(\mp0.01~^{\circ}{ m K})$	$t=rac{T}{T_{ m c}}$	$\begin{array}{c} 2 \Delta(p,t) \\ (\mp 0.01 \text{ meV}) \end{array}$	$2 \Delta/kT_{\rm c} \stackrel{{ m c}}{=} (p,t)$	$\frac{2}{(meV)}$	$\begin{array}{c} 2 A/kT \\ (p, 0) \end{array}$
0	3.42	0.342	1.090	3.69	1.09	3.69
5	3.23	. 0.36	1.01	3.63	1.02	3.66
7	3.15	0.372	0.982	3.62	0.99	3.64
7.9	3.13	0.374	0.974	3.61	0.98	3.64
10.5	3.03	0.387	0.930	3.57	0.94	3.60
14	2.91	0.4	0.880	3.51	0.89	3.55